

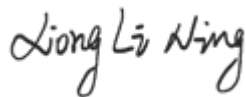
TEST REPORT

Applicant: Seeed Technology Co., Ltd.
Address: 9F, G3 Building, TCL International E City,
Zhongshanyuan Road, Nanshan District, Shenzhen,
Guangdong Province, P.R.C
Equipment Type: Wio-E5-LE Wireless Module
Model Name: Wio-E5-LE-HF
Brand Name: Seeed Studio
FCC ID: Z4T-WIO-E5-LE
Test Standard: 47 CFR Part 2.1091
KDB 447498 D04 v01
Sample Arrival Date: May 26, 2023
Test Date: May 30, 2023 - Jul. 07, 2023
Date of Issue: Jul. 24, 2023

ISSUED BY:

Shenzhen BALUN Technology Co., Ltd.

Tested by: Xiong Lining



Checked by: Xu Rui



Approved by: Tolan Tu
(Testing Director)



Revision History		
Version	Issue Date	Revisions Content
<u>Rev. 01</u>	<u>Jul. 18, 2023</u>	<u>Initial Issue</u>
<u>Rev. 02</u>	<u>Jul. 24, 2023</u>	<u>1. Corrected the Frequency Range in Section 2.5.</u> <u>2. Corrected Section 5.3 RF Exposure Evaluation Result.</u>

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1 GENERAL INFORMATION

1.1 Test Laboratory

Name	Shenzhen BALUN Technology Co., Ltd.
Address	Block B, 1/F, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
Phone Number	+86 755 6685 0100

1.2 Test Location

Name	Shenzhen BALUN Technology Co., Ltd.
Location	<input checked="" type="checkbox"/> Block B, 1/F, Baisha Science and Technology Park, Shahe Xi Road, Nanshan District, Shenzhen, Guangdong Province, P. R. China
	<input type="checkbox"/> 1/F, Building B, Ganghongji High-tech Intelligent Industrial Park, No. 1008, Songbai Road, Yangguang Community, Xili Sub-district, Nanshan District, Shenzhen, Guangdong Province, P. R. China
Accreditation Certificate	The laboratory is a testing organization accredited by FCC as a accredited testing laboratory. The designation number is CN1196.

2 PRODUCT INFORMATION

2.1 Applicant Information

Applicant	Seed Technology Co., Ltd.
Address	9F, G3 Building, TCL International E City, Zhongshanyuan Road, Nanshan District, Shenzhen, Guangdong Province, P.R.C

2.2 Manufacturer Information

Manufacturer	Seed Technology Co., Ltd.
Address	9F, G3 Building, TCL International E City, Zhongshanyuan Road, Nanshan District, Shenzhen, Guangdong Province, P.R.C

2.3 Factory Information

Factory	N/A
Address	N/A

2.4 General Description for Equipment under Test (EUT)

EUT Name	Wio-E5-LE Wireless Module
Model Name Under Test	Wio-E5-LE-HF
Series Model Name	N/A
Description of Model name differentiation	N/A
Hardware Version	v2.0
Software Version	v4.0.11
Dimensions (Approx.)	N/A
Weight (Approx.)	N/A

2.5 Ancillary Equipment

Note: Not applicable.

2.6 Technical Information

Network and Wireless connectivity	LoRa
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The requirement for the following technical information of the EUT was tested in this report:

Operating Mode	LoRa	
Frequency Range	LoRa-DTS	903 MHz ~ 914.2 MHz
	LoRa-Hopping	902.3 MHz ~ 914.9 MHz
Antenna Type	LoRa	Dipole Antenna
Exposure Category	General Population/Uncontrolled Exposure	
EUT Type	Mobile Device	

3 SUMMARY OF TEST RESULT

3.1 Test Standards

No.	Identity	Document Title
1	47 CFR Part 2.1091	Radiofrequency radiation exposure evaluation: mobile devices
2	KDB 447498 D04 v01	447498 D04 Interim General RF Exposure Guidance v01

4 DEVICE CATEGORY AND LEVELS LIMITS

Mobile Device:

CFR Title 47 §2.1091(b)

(b) For purposes of this section, a mobile device is defined as a transmitting device designed to be used in other than fixed locations and to generally be used in such a way that a separation distance of at least 20 centimeters is normally maintained between the transmitter's radiating structure(s) and the body of the user or nearby persons.

FCC KDB 447498 D04 General RF Exposure Guidance v01 Limit

Evaluation of compliance with the exposure limits in § 1.1310 is necessary if the ERP of the device is greater than ERP_{20cm} in Formula (B.1) [repeated from § 2.1091(c)(1) and § 1.1307(b)(1)(i)(B)].

$$P_{th} \text{ (mW)} = ERP_{20 \text{ cm}} \text{ (mW)} = \begin{cases} 2040f & 0.3 \text{ GHz} \leq f < 1.5 \text{ GHz} \\ 3060 & 1.5 \text{ GHz} \leq f \leq 6 \text{ GHz} \end{cases} \quad (\text{B.1})$$

If the ERP is not easily obtained, then the available maximum time-averaged power may be used (i. e., without consideration of ERP only if the physical dimensions of the radiating structure(s) do not exceed the electrical length of $\lambda/4$ or if the antenna gain is less than that of a half-wave dipole.

SAR-based exemptions are constant at separation distances between 20 cm and 40 cm to avoid discontinuities in the threshold when transitioning between SAR-based and MPE-based exemption criteria at 40 cm, considering the importance of reflections.

The SAR-based exemption formula of § 1.1307(b)(3)(i)(B), repeated here as Formula (B.2), applies for single fixed, mobile, and portable RF sources with available maximum time-averaged power or effective radiated power (ERP), whichever is greater, of less than or equal to the threshold P_{th} (mW).

This method shall only be used at separation distances from 0.5 cm to 40 cm and at frequencies from 0.3 GHz to 6 GHz (inclusive). P_{th} is given by Formula (B.2).

$$P_{th} \text{ (mW)} = \begin{cases} ERP_{20 \text{ cm}} (d/20 \text{ cm})^x & d \leq 20 \text{ cm} \\ ERP_{20 \text{ cm}} & 20 \text{ cm} < d \leq 40 \text{ cm} \end{cases} \quad \text{(B.2)}$$

where

$$x = -\log_{10} \left(\frac{60}{ERP_{20 \text{ cm}} \sqrt{f}} \right)$$

and f is in GHz, d is the separation distance (cm), and $ERP_{20\text{cm}}$ is per Formula (B.1). The example values shown in Table B.2 are for illustration only.

Table B.2—Example Power Thresholds (mW)

Frequency (MHz)	Distance (mm)									
	5	10	15	20	25	30	35	40	45	50
300	39	65	88	110	129	148	166	184	201	217
450	22	44	67	89	112	135	158	180	203	226
835	9	25	44	66	90	116	145	175	207	240
1900	3	12	26	44	66	92	122	157	195	236
2450	3	10	22	38	59	83	111	143	179	219
3600	2	8	18	32	49	71	96	125	158	195
5800	1	6	14	25	40	58	80	106	136	169

5 ASSESSMENT RESULT

5.1 Output Power

LoRa-DTS	
Conducted Power (dBm)	12.95
Antenna Gain (dBi)	2.40
EIRP (dBm)	15.35
Note: This report listed the worst case power value, please refer to BL-SZ2351174-601 report for more details.	

LoRa-Hopping	
Conducted Power (dBm)	13.02
Antenna Gain (dBi)	2.40
EIRP (dBm)	15.42
Note: This report listed the worst case power value, please refer to BL-SZ2351174-602 report for more details.	

5.2 Tune-up power

Mode	Conducted Power Range (dBm)	EIRP Range (dBm)	ERP Range (dBm)
Max. LoRa	[11.50, 13.50]	[14.00, 16.00]	[11.85, 13.85]
Note 1: ERP= EIRP -2.15dB			
Note 2: According KDB 447498 D04, used the greater of maximum conducted power and ERP to compare with the threshold value Pth.			

5.3 RF Exposure Evaluation Result

Mode	Distance (mm)	Calculation Frequency (MHz)	Tune-up limit power (dBm)	Tune-up limit power (mW)	Threshold Power (mW)	Verdict
Max. LoRa	200	914.90	13.85	24.27	1866.40	Pass

5.4 Conclusion

This EUT is deemed to comply with the reference level limits, therefore the basic restrictions are compliant with human exposure limits.

Statement

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--END OF REPORT--